Ingun E-Type test probe E-075 214 064 A 2000

Item E-075-0033





- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.

General data

Product group ICT / FCT (in-circuit test and function test Sub-product group INGUN E-TYPE® Series E-075 1.91 mm [75 mil] Grid Contacting from Pad, Pin, Post Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No Compatible receptacle(s) KS-075 - 40 °C [- 104 °F] Min. temperature Max. temperature +80 °C [+176 °F] RoHS-compliant RoHS-3;6a

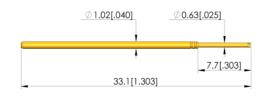


Electrical data

Current load capacity / rated current 3 A Typical resistance (Ri) <20 mOhm

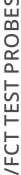


Total length 33.1 mm [1.30 in] Barrel diameter 1.02 mm [.040 in] Maximum stroke 6.35 mm [.25 in] Spring pre-load 1.11 N [3.99 ozf] Collar height 00 Spring force at working stroke 2 N [7.19 ozf] Recommended working stroke 4.3 mm [.169 in]



Tip style data

Tip style 14 4-point crown, self-cleaning Tip diameter 0.64 mm [.025 in] Tip style surface A gold Tip style material 2 steel

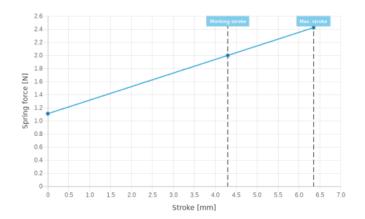


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Learn more about ICT/FCT Test probes

